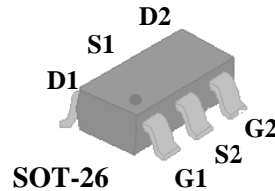




- ▼ Low Gate Charge Drive
- ▼ Low On-resistance
- ▼ Surface Mount Package
- ▼ RoHS Compliant

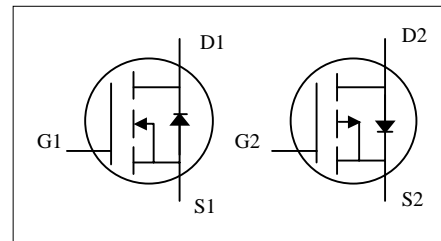


N-CH	$BV_{DSS}$	16V
	$R_{DS(ON)}$	58m $\Omega$
	$I_D$	3.5A
P-CH	$BV_{DSS}$	-16V
	$R_{DS(ON)}$	125m $\Omega$
	$I_D$	-2.5A

## Description

Advanced Power MOSFETs utilized advanced processing techniques to achieve the lowest possible on-resistance, extremely efficient and cost-effectiveness device.

The SOT-26 package is universally used for all commercial-industrial applications.



## Absolute Maximum Ratings

Symbol	Parameter	Rating		Units
		N-channel	P-channel	
$V_{DS}$	Drain-Source Voltage	16	-16	V
$V_{GS}$	Gate-Source Voltage	$\pm 8$	$\pm 8$	V
$I_D @ T_A = 25^\circ C$	Continuous Drain Current <sup>3</sup>	3.5	-2.5	A
$I_D @ T_A = 70^\circ C$	Continuous Drain Current <sup>3</sup>	2.8	-2	A
$I_{DM}$	Pulsed Drain Current <sup>1</sup>	10	-10	A
$P_D @ T_A = 25^\circ C$	Total Power Dissipation	1.14		W
	Linear Derating Factor	0.01		W/ $^\circ C$
$T_{STG}$	Storage Temperature Range	-55 to 150		$^\circ C$
$T_J$	Operating Junction Temperature Range	-55 to 150		$^\circ C$

## Thermal Data

Symbol	Parameter	Value	Unit
Rthj-a	Thermal Resistance Junction-ambient <sup>3</sup>	Max. 110	$^\circ C/W$



# AP2531GY

## N-CH Electrical Characteristics @T<sub>j</sub>=25°C(unless otherwise specified)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V, I <sub>D</sub> =250uA	16	-	-	V
ΔBV <sub>DSS</sub> /ΔT <sub>j</sub>	Breakdown Voltage Temperature Coefficient	Reference to 25°C, I <sub>D</sub> =1mA	-	0.01	-	V/°C
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance <sup>2</sup>	V <sub>GS</sub> =4.5V, I <sub>D</sub> =3A	-	-	58	mΩ
		V <sub>GS</sub> =2.5V, I <sub>D</sub> =2A	-	-	70	mΩ
		V <sub>GS</sub> =1.8V, I <sub>D</sub> =1A	-	-	85	mΩ
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250uA	0.2	-	1	V
g <sub>fs</sub>	Forward Transconductance	V <sub>DS</sub> =5V, I <sub>D</sub> =3A	-	9	-	S
I <sub>DSS</sub>	Drain-Source Leakage Current (T <sub>j</sub> =25°C)	V <sub>DS</sub> =16V, V <sub>GS</sub> =0V	-	-	1	uA
	Drain-Source Leakage Current (T <sub>j</sub> =70°C)	V <sub>DS</sub> =12V, V <sub>GS</sub> =0V	-	-	25	uA
I <sub>GSS</sub>	Gate-Source Leakage	V <sub>GS</sub> =±8V	-	-	±100	nA
Q <sub>g</sub>	Total Gate Charge <sup>2</sup>	I <sub>D</sub> =3A V <sub>DS</sub> =10V V <sub>GS</sub> =4.5V	-	7	12	nC
Q <sub>gs</sub>	Gate-Source Charge		-	0.6	-	nC
Q <sub>gd</sub>	Gate-Drain ("Miller") Charge		-	2	-	nC
t <sub>d(on)</sub>	Turn-on Delay Time <sup>2</sup>	V <sub>DS</sub> =10V I <sub>D</sub> =1A R <sub>G</sub> =3.3Ω, V <sub>GS</sub> =5V R <sub>D</sub> =10Ω	-	6	-	ns
t <sub>r</sub>	Rise Time		-	11	-	ns
t <sub>d(off)</sub>	Turn-off Delay Time		-	17	-	ns
t <sub>f</sub>	Fall Time		-	3	-	ns
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> =0V	-	360	580	pF
C <sub>oss</sub>	Output Capacitance	V <sub>DS</sub> =25V	-	50	-	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	f=1.0MHz	-	40	-	pF
R <sub>g</sub>	Gate Resistance	f=1.0MHz	-	1.4	2	Ω

## Source-Drain Diode

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
V <sub>SD</sub>	Forward On Voltage <sup>2</sup>	I <sub>S</sub> =0.9A, V <sub>GS</sub> =0V	-	-	1.3	V



**P-CH Electrical Characteristics @T<sub>j</sub>=25°C(unless otherwise specified)**

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V, I <sub>D</sub> =-250uA	-16	-	-	V
ΔBV <sub>DSS</sub> /ΔT <sub>j</sub>	Breakdown Voltage Temperature Coefficient	Reference to 25°C, I <sub>D</sub> =-1mA	-	0.01	-	V/°C
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-2A	-	-	125	mΩ
		V <sub>GS</sub> =-2.5V, I <sub>D</sub> =-1.6A	-	-	155	mΩ
		V <sub>GS</sub> =-1.8V, I <sub>D</sub> =-1A	-	-	200	mΩ
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =-250uA	-0.2	-	-1	V
g <sub>fs</sub>	Forward Transconductance	V <sub>DS</sub> =-5V, I <sub>D</sub> =-2A	-	5	-	S
I <sub>DSS</sub>	Drain-Source Leakage Current (T=25°C)	V <sub>DS</sub> =-16V, V <sub>GS</sub> =0V	-	-	-1	uA
	Drain-Source Leakage Current (T=70°C)	V <sub>DS</sub> =-12V, V <sub>GS</sub> =0V	-	-	-25	uA
I <sub>GSS</sub>	Gate-Source Leakage	V <sub>GS</sub> =±8V	-	-	±100	nA
Q <sub>g</sub>	Total Gate Charge <sup>2</sup>	I <sub>D</sub> =-2A	-	6	10	nC
Q <sub>gs</sub>	Gate-Source Charge	V <sub>DS</sub> =-10V	-	0.8	-	nC
Q <sub>gd</sub>	Gate-Drain ("Miller") Charge	V <sub>GS</sub> =-4.5V	-	2	-	nC
t <sub>d(on)</sub>	Turn-on Delay Time <sup>2</sup>	V <sub>DS</sub> =-10V	-	7	-	ns
t <sub>r</sub>	Rise Time	I <sub>D</sub> =-1A	-	20	-	ns
t <sub>d(off)</sub>	Turn-off Delay Time	R <sub>G</sub> =3.3Ω, V <sub>GS</sub> =-5V	-	23	-	ns
t <sub>f</sub>	Fall Time	R <sub>D</sub> =10Ω	-	24	-	ns
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> =0V	-	370	600	pF
C <sub>oss</sub>	Output Capacitance	V <sub>DS</sub> =-25V	-	70	-	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	f=1.0MHz	-	60	-	pF
R <sub>g</sub>	Gate Resistance	f=1.0MHz	-	8	12	Ω

**Source-Drain Diode**

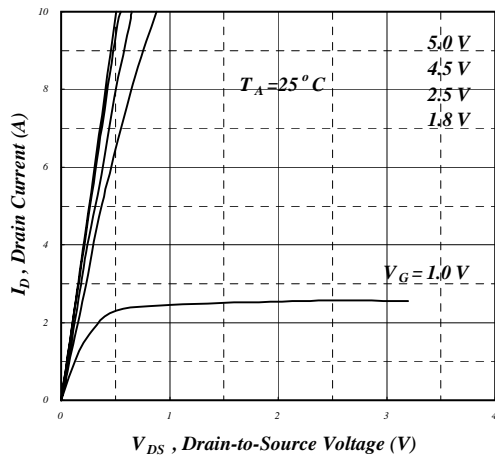
Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
V <sub>SD</sub>	Forward On Voltage <sup>2</sup>	I <sub>S</sub> =-0.9A, V <sub>GS</sub> =0V	-	-	-1.3	V

**Notes:**

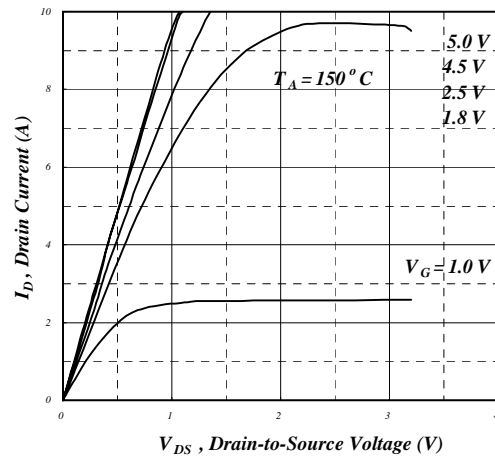
- 1.Pulse width limited by Max. junction temperature.
- 2.Pulse width ≤300us , duty cycle ≤2%.
- 3.Surface mounted on 1 in<sup>2</sup> copper pad of FR4 board, t<sub>≤</sub>5sec ; 180°C/W when mounted on min. copper pad.



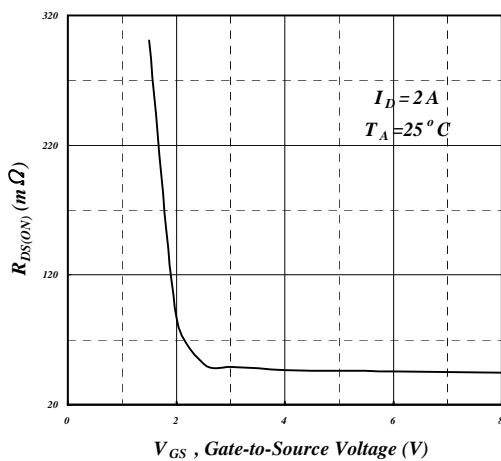
## N-Channel



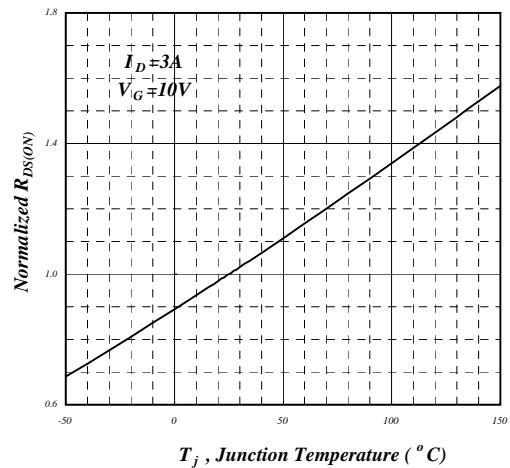
**Fig 1. Typical Output Characteristics**



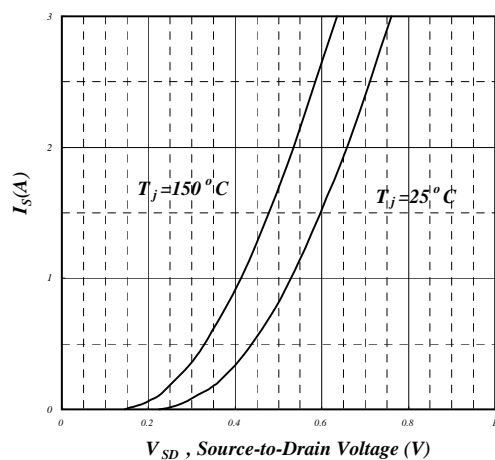
**Fig 2. Typical Output Characteristics**



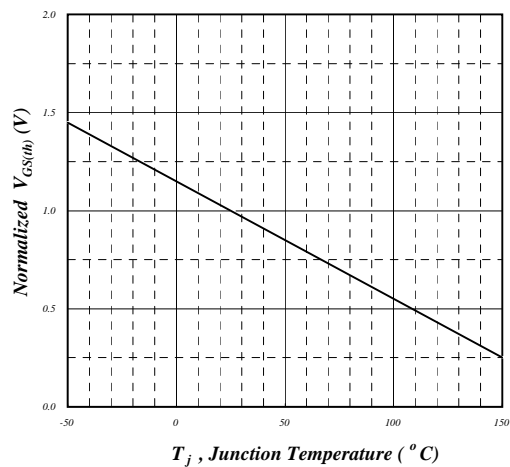
**Fig 3. On-Resistance v.s. Gate Voltage**



**Fig 4. Normalized On-Resistance v.s. Junction Temperature**



**Fig 5. Forward Characteristic of Reverse Diode**



**Fig 6. Gate Threshold Voltage v.s. Junction Temperature**



N-Channel

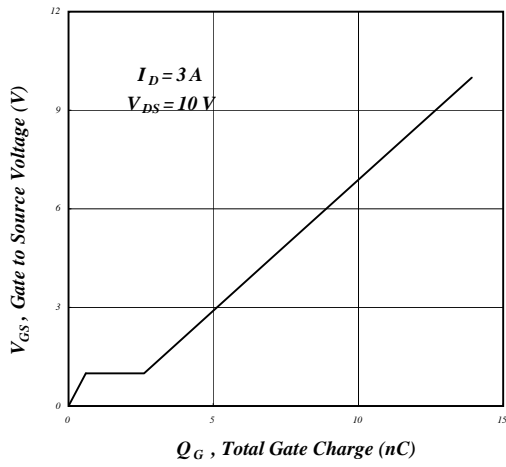


Fig 7. Gate Charge Characteristics

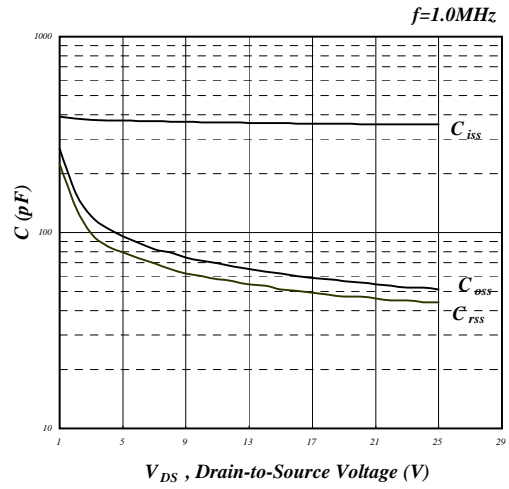


Fig 8. Typical Capacitance Characteristics

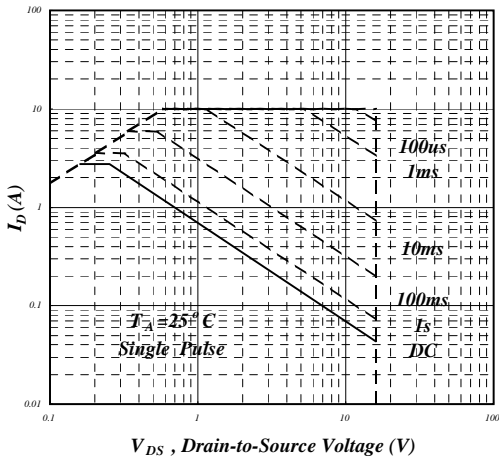


Fig 9. Maximum Safe Operating Area

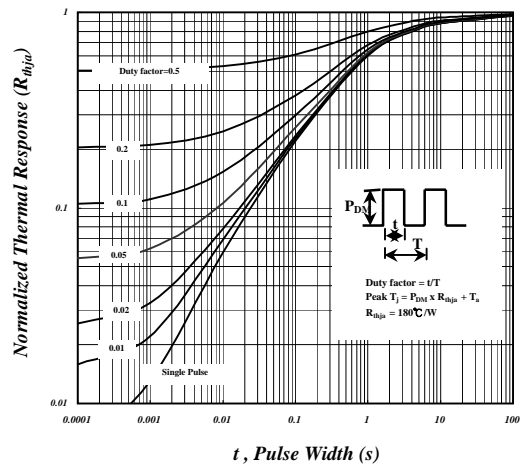


Fig 10. Effective Transient Thermal Impedance

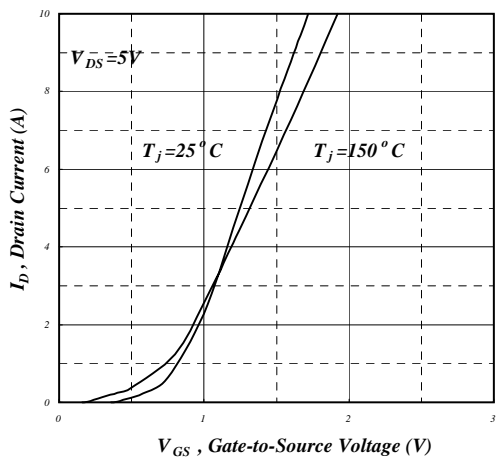


Fig 11. Transfer Characteristics

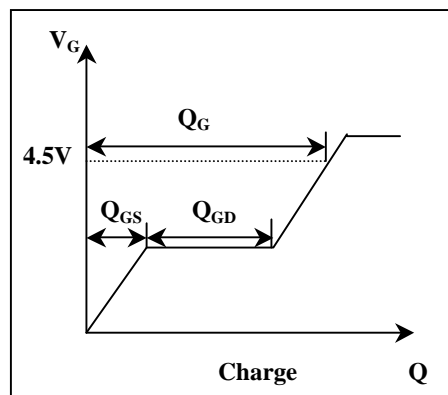
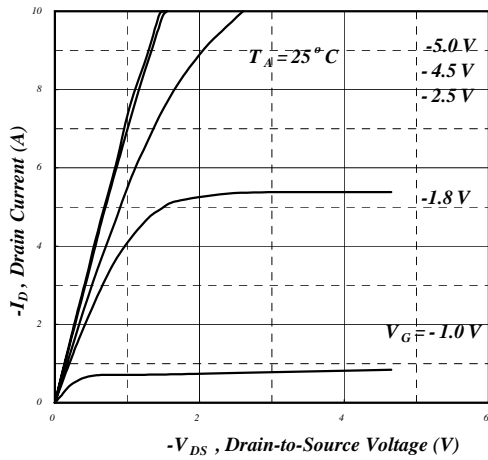


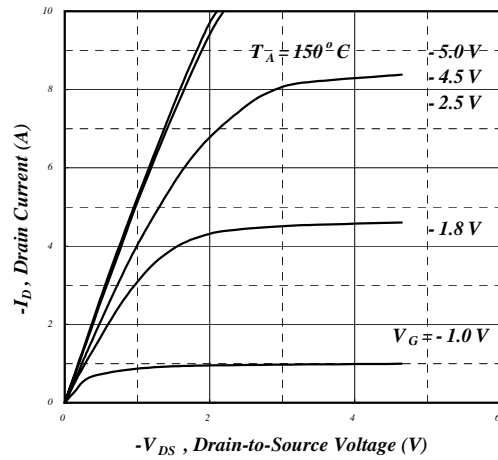
Fig 12. Gate Charge Waveform



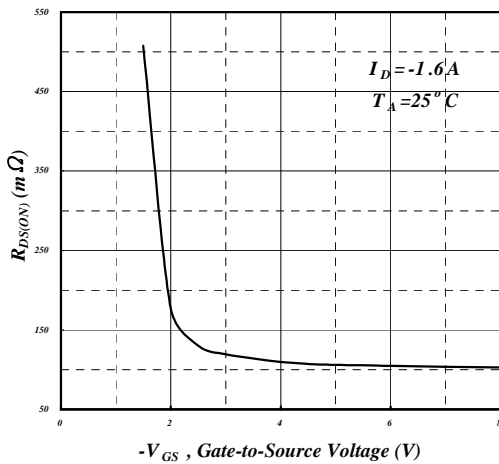
## P-Channel



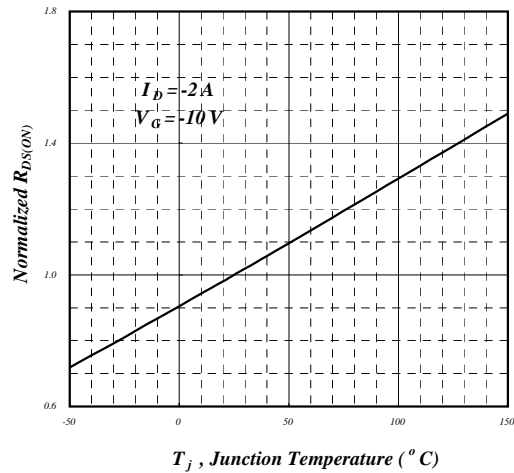
**Fig 1. Typical Output Characteristics**



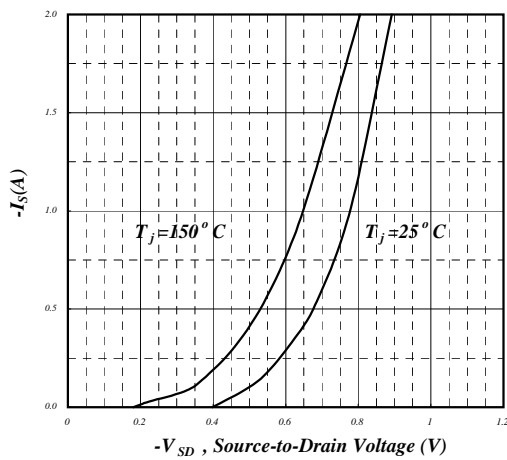
**Fig 2. Typical Output Characteristics**



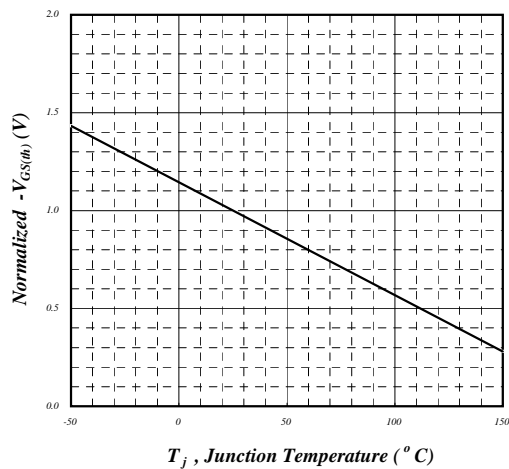
**Fig 3. On-Resistance v.s. Gate Voltage**



**Fig 4. Normalized On-Resistance v.s. Junction Temperature**



**Fig 5. Forward Characteristic of Reverse Diode**



**Fig 6. Gate Threshold Voltage v.s. Junction Temperature**



P-Channel

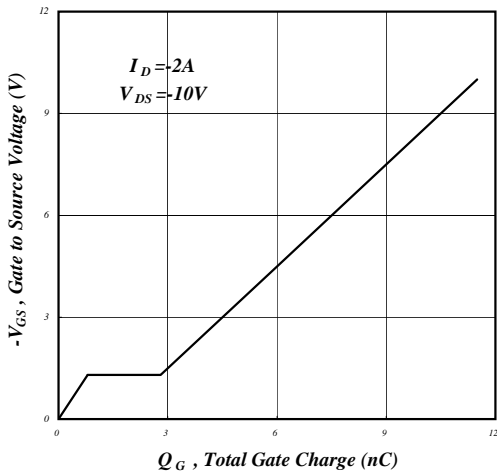


Fig 7. Gate Charge Characteristics

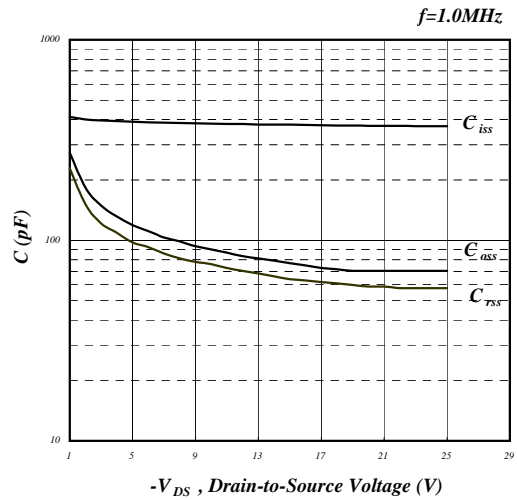


Fig 8. Typical Capacitance Characteristics

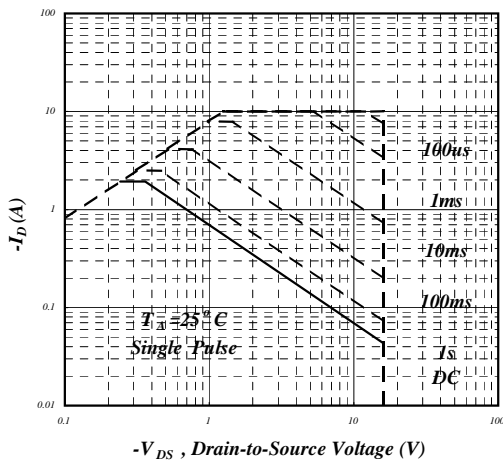


Fig 9. Maximum Safe Operating Area

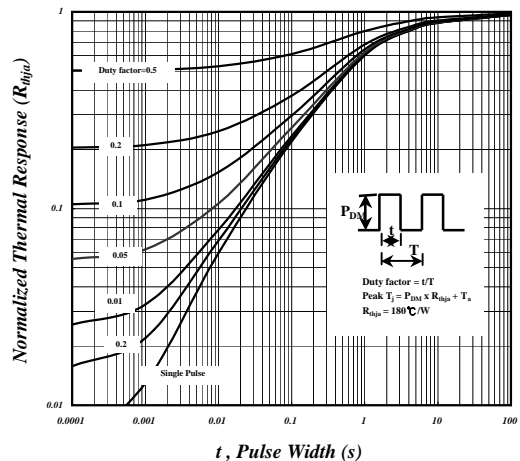


Fig 10. Effective Transient Thermal Impedance

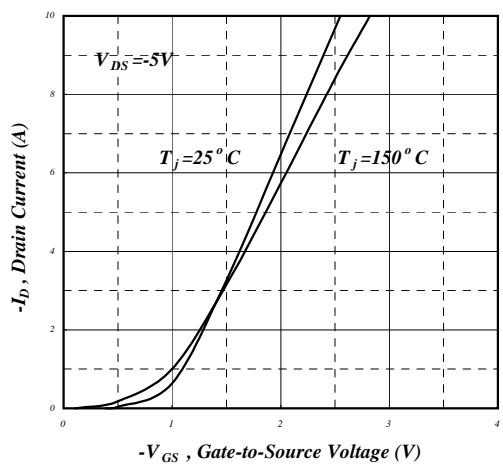


Fig 11. Transfer Characteristics

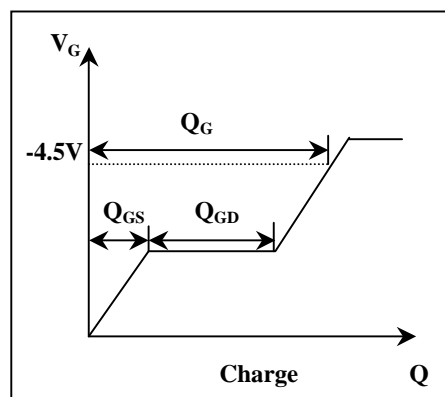


Fig 12. Gate Charge Waveform